

Search Notes

Application/Control No.

10/849,954

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

YAMADA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	updated	1/4/2006	<i>SWH</i> SWH
358	updated	1/4/2006	<i>SWH</i> SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPGPUB (see attached)	1/4/2006	<i>SWH</i> SWH